Application/Control No. Applicant(s)/Patent Under Reexamination 10/644,583 GRECH ET AL. Notice of References Cited **Art Unit** Examiner Page 1 of 1 David M. Naff 1651 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 10-1997 Yamasaki et al. 210/602 US-5,676,836 Α * 04-2002 435/174 US-6,365,384 B1 lijima, Ryusuke В * 11-2001 Walker et al. 424/93.4 US-6,322,782 B1 С US-D Ε US-F US-US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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